Notice of References Cited

Application/Control No. 10/708,532	Applicant(s)/l Reexamination JENSEN, KE	on
Examiner	Art Unit	
Oanh Duong	2155	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0154837	07-2005	Keohane et al.	711/138
*	В	US-2004/0205197 A1	10-2004	Schlereth, Michael	709/228
*	C	US-6,819,444 B1	11-2004	Yamagishi, Yoichi	358/1.15
*	D	US-2004/0205650 A1	10-2004	Cheng, Lebin	715/530
*	Ш	US-2003/0043844 A1	03-2003	Heller, Howard A.	370/466
*	F	US-2004/0225922 A	11-2004	Susarla et al.	714/038
	G	US-			
	H	US-		·	
	Ī	US-			
	J	US-			
	K	US-			
	. L	US			
	Μ	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004348766 A	12-2004	Japan	ASAHI, TSUNEMORI	
	0	JP 11055304 A	02-1999	Japan	MIYAMOTO et al.	
	Р					
	Q					
	R				,	
	S					
	Т					

NON-PATENT DOCUMENTS

*	-	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	>						
	W						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.